

Search Notes



Application/Control No.

10/644,182

Examiner

José V. Chen

Applicant(s)/Patent under Reexamination

BUECHLER, JAMES G.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
108	180	6/7/05	JLC
	105		
	180		
	180		
	190		
	143		
	153.1		
	155		
	157.18		
	158.12		
312	257.1		
	265.1		
	265.2		
	195		
250	180	11/16/05	JLC
	180.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
108	180	1/15/06	JLC
	158.12		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Front & back.	6/7/05	JLC
CITATIONS FOR		
POLE ART.		
ADT 2007	11/16/05	JLC
UPDA 2007	1/3/06	JLC
FOR		
FOR SEARCH (25)		